

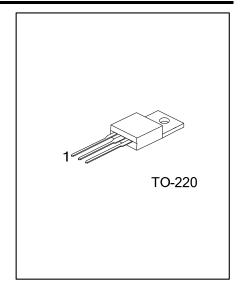
# **UTC** UNISONIC TECHNOLOGIES CO., LTD

# US112S/N

## **SCRS**

#### DESCRIPTION

The UTC US112S/N is suitable to fit all modes of control found in applications such as overvoltage crowbar protection, motor control circuits in power tools and kitchen aids, in-rush current limiting circuits, capacitive discharge ignition, voltage regulation circuits



#### **ORDERING INFORMATION**

Ordering Number		Deekere	Pin Assignment			De elsiere	
Lead Free	Halogen Free	Package	1	2	3	Packing	
US112SL-4-TA3-T	US112SG-4-TA3-T	TO-220	K	А	G	Tube	
US112SL-6-TA3-T	US112SG-6-TA3-T	TO-220	K	А	G	Tube	
US112SL-8-TA3-T	US112SG-8-TA3-T	TO-220	K	А	G	Tube	
US112NL-4-TA3-T	2NL-4-TA3-T US112NG-4-TA3-T		K	А	G	Tube	
US112NL-6-TA3-T	.3-T US112NG-6-TA3-T		K	А	G	Tube	
US112NL-8-TA3-T	US112NG-8-TA3-T	TO-220	K	А	G	Tube	

Note: Pin Assignment: K: Cathode G: Gate A: Anode

US112SL-4-TA3-T [ ] (1)Packing Type	(1) T: Tube
(2)Package Type	(2) TA3: TO-220
(3)Lead Free	(3) G: Halogen Free, L: Lead Free

## 1 of 3

QW-R301-013.Ca

### ■ ABSOLUTE MAXIMUM RATING

PARAMETER			RATING	UNIT
	US112S/N-4	V	400	
Repetitive Peak Off-State Voltages	US112S/N-6	V <sub>DRM</sub> V <sub>RRM</sub>	600	V
	US112S/N-8		800	
RMS On-State Current (180°Conduction Angle) (	I <sub>T(RMS)</sub>	12	А	
Average On-State Current (180°Conduction Angle) (T <sub>c</sub> = 110°C)			8	Α
Non Repetitive Surge Peak On-State Current	t <sub>P</sub> =8.3ms	I <sub>T(AV)</sub>	146	^
(T <sub>J</sub> = 25℃)	t <sub>P</sub> =10ms	I <sub>TSM</sub>	140	A
l²t Value For Fusing (t <sub>P</sub> = 10 ms ,T <sub>J</sub> = 25 $^{\circ}$ C)	l²t	98	A²S	
Critical Rate Of Rise Of On-State Current ( $I_G = 2 \times I_{GT}$ , $t_R \le 100 \text{ ns}$ , $T_J = 125^{\circ}C$ )			50	A/µs
Peak Gate Current (t <sub>P</sub> =20µs, F = 60 Hz, T <sub>J</sub> =125°	I <sub>GM</sub>	4	Α	
Peak Reverse Gate Voltage	US112N	V <sub>RGM</sub>	5	V
Average Gate Power Dissipation (T <sub>J</sub> = 125°C)			1	W
Storage Temperature			-40 ~ +150	°C
Junction Temperature	ТJ	+125	°C	

Note 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

#### THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	$\theta_{JA}$	60	K/W
Junction to Case	θ <sub>JC</sub>	1.3	K/W

#### ■ ELECTRICAL CHARACTERISTICS (T<sub>J</sub>=25°C unless otherwise specified)

#### US112S(SENSITIVE)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Gate Trigger Current	I <sub>GT</sub>	V <sub>D</sub> = 12V, R <sub>L</sub> =140Ω			200	μA
Gate Trigger Voltage	$V_{GT}$	V <sub>D</sub> = 12V, R <sub>L</sub> =140Ω			0.8	V
Gate Non-Trigger Voltage	$V_{\text{GD}}$	V <sub>D</sub> = V <sub>DRM</sub> , R <sub>L</sub> = 3.3kΩ, R <sub>GK</sub> = 1KΩ, T <sub>J</sub> = 125℃	0.1			V
Reverse Gate Voltage	$V_{RG}$	I <sub>RG</sub> = 10 μΑ	8			V
Holding Current	Ι <sub>Η</sub>	I <sub>T</sub> = 50mA, R <sub>GK</sub> = 1kΩ			5	mA
Latching Current	ΙL	$I_G = 1 \text{mA}$ , $R_{GK} = 1 \text{k}\Omega$			6	mA
Circuit Rate of Change of Off-State Voltage	dV/dt	$V_{D} = 67\% V_{DRM}, R_{GK} = 220\Omega$	5			V/µs
On-State Voltage	V <sub>TM</sub>	I <sub>TM</sub> =24A, t <sub>P</sub> = 380 μs			1.6	V
Threshold Voltage	V <sub>T0</sub>	T」= 125℃			0.85	V
Dynamic Resistance	$R_{D}$	T」 = 125℃			30	mΩ
Off-State Leakage Current	I <sub>DRM</sub>	$V_{DRM} = V_{RRM}, R_{GK} = 220\Omega$			5	μA
	I <sub>RRM</sub>	V <sub>DRM</sub> = V <sub>RRM,</sub> R <sub>GK</sub> =220Ω, T <sub>J</sub> = 125°C			2	mA



## ■ ELECTRICAL CHARACTERISTICS(Cont.)

#### US112N(SENSITIVE)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Gate Trigger Current	I <sub>GT</sub>	V <sub>D</sub> = 12 V, R <sub>L</sub> =33Ω	2		15	mA
Gate Trigger Voltage	$V_{GT}$	V <sub>D</sub> = 12 V, R <sub>L</sub> =33Ω			1.3	V
Gate Non-Trigger Voltage	$V_{GD}$	V <sub>D</sub> =V <sub>DRM</sub> , R <sub>L</sub> = 3.3kΩ,T <sub>J</sub> =125°C	0.2			V
Holding Current	I <sub>H</sub>	I⊤ = 500mA Gate open			30	mA
Latching Current	١L	$I_{\rm G} = 1.2 I_{\rm GT}$			60	mA
Circuit Rate of Change of Off-State Voltage	dV/dt	V <sub>D</sub> =67%V <sub>DRM</sub> Gate open, T <sub>J</sub> =125℃	200			V/µs
On-State Voltage	V <sub>TM</sub>	I <sub>TM</sub> =24 A, t <sub>P</sub> = 380 μs			1.6	V
Threshold Voltage	V <sub>T0</sub>	T」= 125℃			0.85	V
Dynamic Resistance	RD	T」= 125℃			30	mΩ
Off State Laskage Current	<b>I</b> DRM	$V_{DRM} = V_{RRM}$			5	μA
Off-State Leakage Current	I <sub>RRM</sub>	V <sub>DRM</sub> = V <sub>RRM</sub> , T <sub>J</sub> = 125℃			2	mA

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